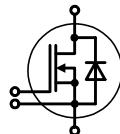


# HiPerFET™ Power MOSFETs

in ECO-PAC 2  
(Electrically Isolated Back Surface)

Single MOSFET



Pin arrangement see outlines

## MOSFET

Symbol	Conditions	Maximum Ratings		
$V_{DSS}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	100		V
$V_{DGR}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$ ; $R_{GS} = 1 \text{ M}\Omega$	100		V
$V_{GS}$	Continuous	$\pm 20$		V
$V_{GSM}$	Transient	$\pm 30$		V
$I_{D25}$	$T_c = 25^\circ\text{C}$ (MOSFET chip capability)	165		A
$I_{D(RMS)}$	External lead (current limit)	76		A
$I_{DM}$	$T_c = 25^\circ\text{C}$ <sup>1)</sup>	720		A
$I_{AR}$	$T_c = 25^\circ\text{C}$	180		A
$E_{AR}$	$T_c = 25^\circ\text{C}$	60		$\text{mJ}$
$E_{AS}$	$T_c = 25^\circ\text{C}$	3		J
$dv/dt$	$I_s \leq I_{DM}$ , $di/dt \leq 100 \text{ A}/\mu\text{s}$ , $V_{DD} \leq V_{DSS}$ $T_J \leq 150^\circ\text{C}$ , $R_G = 2 \Omega$	5		V/ns
$P_D$	$T_c = 25^\circ\text{C}$	400		W

Symbol	Conditions	Characteristic Values		
		( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	min.	typ.
$V_{DSS}$	$V_{GS} = 0 \text{ V}$ , $I_D = 3 \text{ mA}$	100		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 8 \text{ mA}$	2.0		V
$I_{GSS}$	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0$		$\pm 100$	nA
$I_{DSS}$	$V_{DS} = V_{DSS}$ ; $T_J = 25^\circ\text{C}$ $V_{GS} = 0 \text{ V}$ ; $T_J = 125^\circ\text{C}$		100	$\mu\text{A}$
$I_{DSS(on)}$	$V_{GS} = 10 \text{ V}$ , $I_D = 90 \text{ A}$ <sup>1)</sup>		2	mA
$g_{fs}$	$V_{DS} = 10 \text{ V}$ ; $I_D = 90 \text{ A}$ <sup>2)</sup>	60	90	S
$C_{iss}$ $C_{oss}$ $C_{rss}$	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	9400 3200 1660		pF
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	$V_{GS} = 10 \text{ V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 90 \text{ A}$ $R_G = 1 \Omega$ (External)	50 90 140 65		ns
$Q_{g(on)}$ $Q_{gs}$ $Q_{gd}$	$V_{GS} = 10 \text{ V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 90 \text{ A}$	400 65 220		nC
$R_{thJC}$ $R_{thCK}$	with heatsink compound (0.42 K/m.K; 50 $\mu\text{m}$ )	0.2	0.30	K/W

IXYS reserves the right to change limits, test conditions and dimensions.

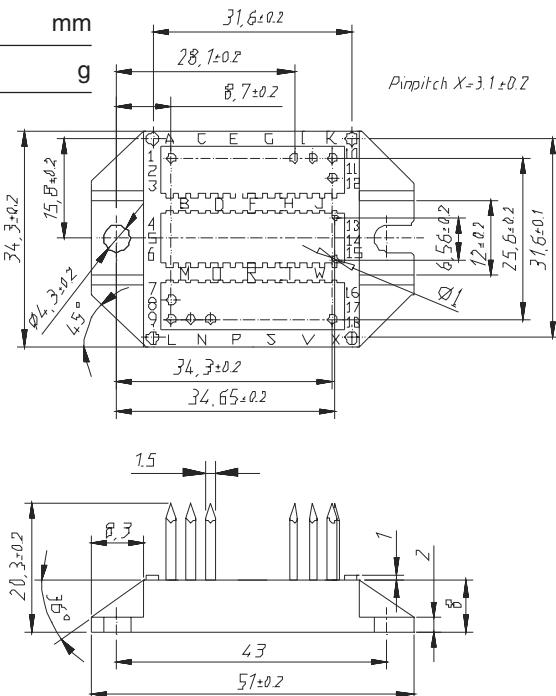
**Source-Drain Diode****Characteristic Values**(T<sub>J</sub> = 25°C, unless otherwise specified)

Symbol	Conditions	min.	typ.	max.
I <sub>S</sub>	V <sub>GS</sub> = 0 V		180	A
I <sub>SM</sub>	Repetitive; pulse width limited by T <sub>JM</sub>		720	A
V <sub>SD</sub>	I <sub>F</sub> = 100A, V <sub>GS</sub> = 0 V, <sup>1)</sup>		1.5	V
t <sub>rr</sub>			250	ns
Q <sub>RM</sub>		1.1		μC
I <sub>RM</sub>		13		A

Note: <sup>1)</sup> Pulse width limited by T<sub>JM</sub><sup>2)</sup> Pulse test, t ≤ 300 μs, duty cycle d ≤ 2 %**Module**

Symbol	Conditions	Maximum Ratings		
T <sub>VJ</sub>		-40...+150		°C
T <sub>stg</sub>		-40...+125		°C
V <sub>ISOL</sub>	I <sub>ISOL</sub> ≤ 1 mA; 50/60 Hz; t = 1 s	3600		V~
M <sub>d</sub>	mounting torque (M4)	1.5 - 2.0		Nm
		14 - 18		lb.in.
a	Max. allowable acceleration	50		m/s <sup>2</sup>

Symbol	Conditions	Characteristic Values		
		min.	typ.	max.
d <sub>S</sub>	Creepage distance on surface (Pin to heatsink)	11.2		mm
d <sub>A</sub>	Strike distance in air (Pin to heatsink)	11.2		mm
Weight		24		g

**Dimensions in mm (1 mm = 0.0394")**

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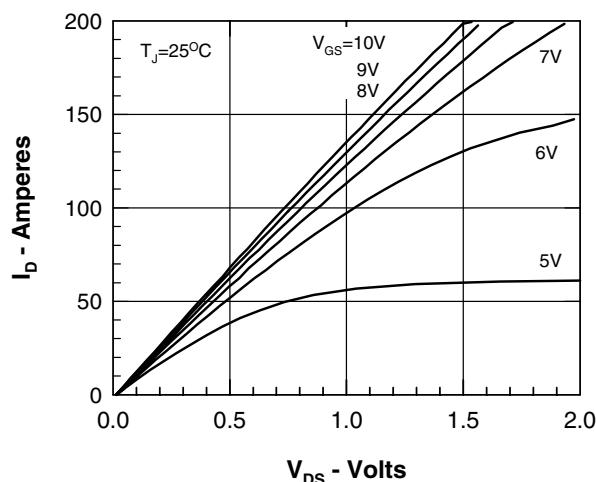


Figure 1. Output Characteristics at  $25^\circ\text{C}$

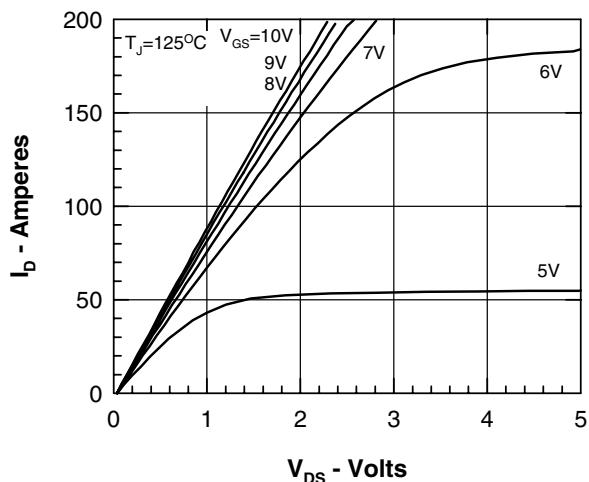


Figure 2. Output Characteristics at  $125^\circ\text{C}$

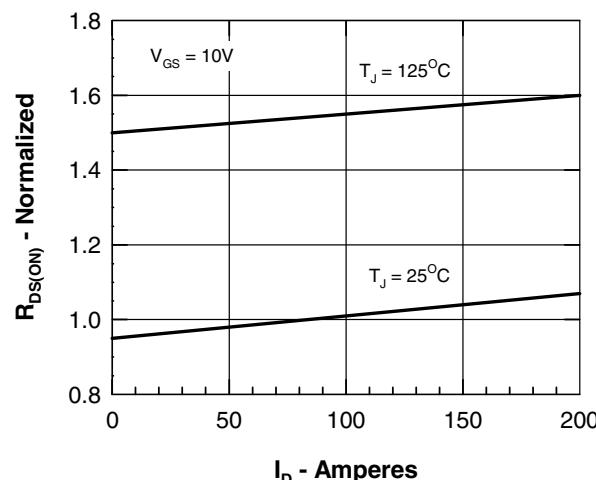


Figure 3.  $R_{DS(on)}$  normalized to  $15\text{A}/25^\circ\text{C}$  vs.  $I_D$

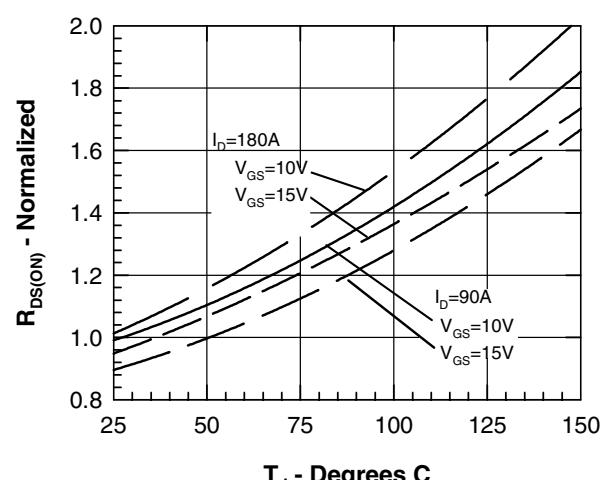


Figure 4.  $R_{DS(on)}$  normalized to  $15\text{A}/25^\circ\text{C}$  vs.  $T_J$

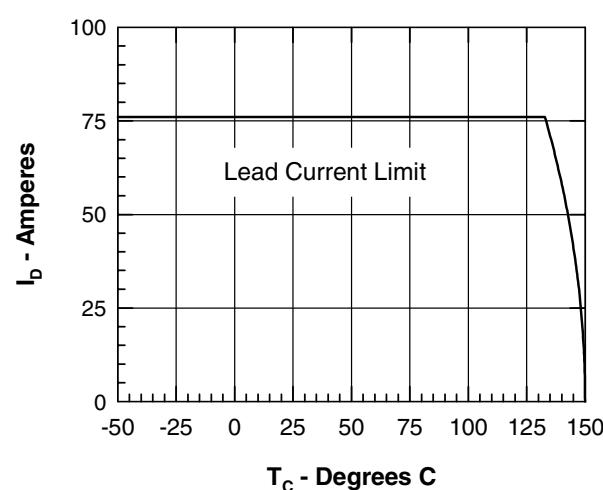


Figure 5. Drain Current vs. Case Temperature

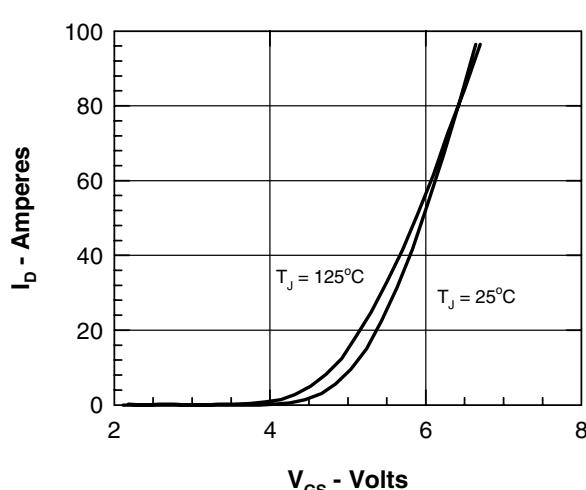


Figure 6. Admittance Curves

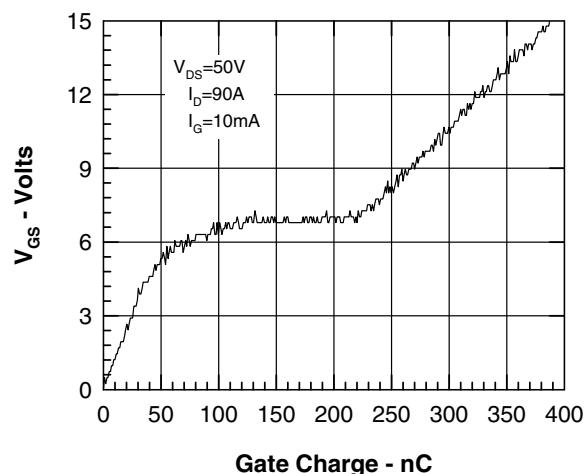


Figure 7. Gate Charge

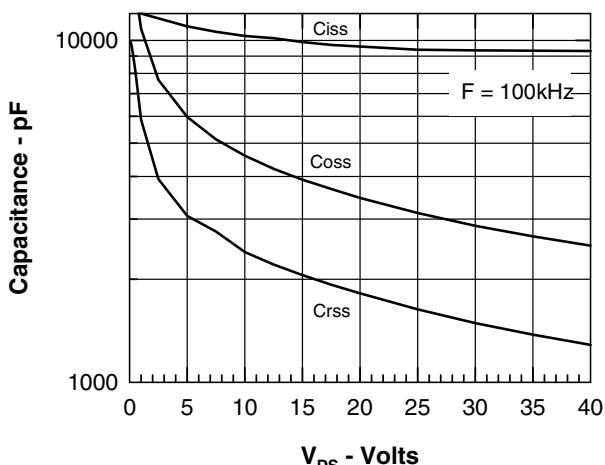


Figure 8. Capacitance Curves

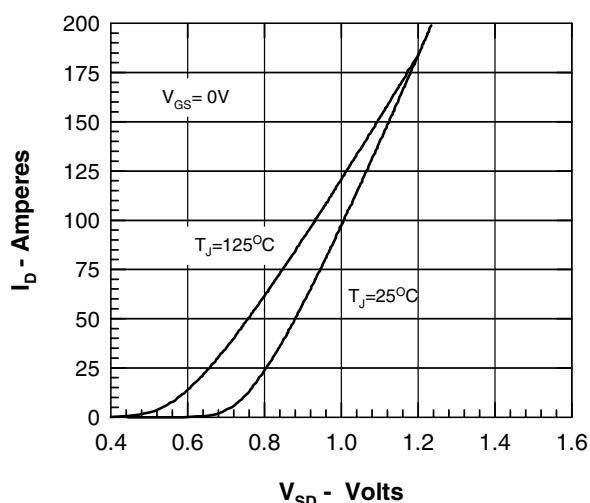


Figure 9. Forward Voltage Drop of the Intrinsic Diode

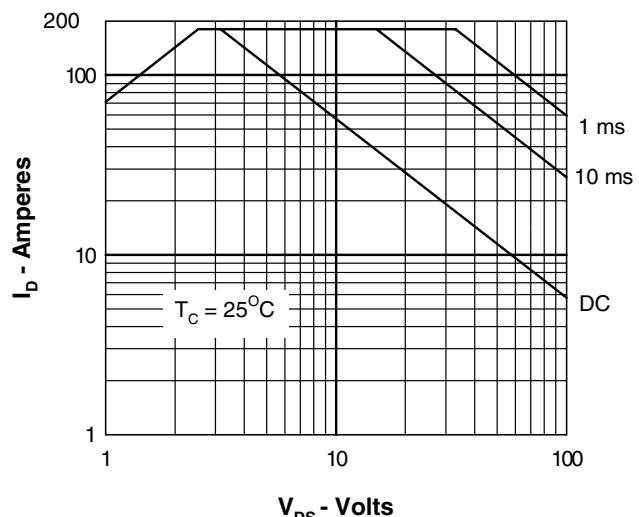


Figure 10. Forward Bias Safe Operating Area

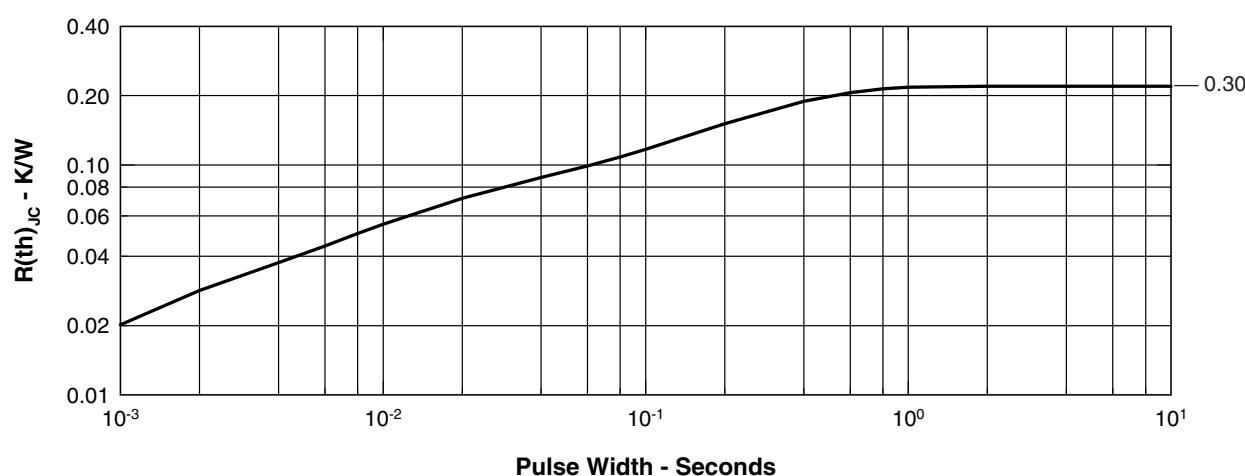


Figure 11. Typical Transient Thermal Resistance